

Notice of References Cited	Application/Control No. 10/519,410	Applicant(s)/Patent Under Reexamination EGAWA, YOSUKE	
	Examiner Alicia M. Toscano	Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,326,440	12-2001	Terada et al.	525/411
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	M	US-			

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NON-PATENT DOCUMENTS

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*	U	English translation of JP 2001049098A
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.